

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/560,723 EINSTEIN ET AL.	
		Examiner	Art Unit SEAN E. AEDER	1642 Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,812,339 B1	11-2004	Venter et al.	536/24.31
	B	US-			
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	D	US-			
	E	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N	WO 01/60860 A2	08-2001		Schlegel et al	C07K 14/47
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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